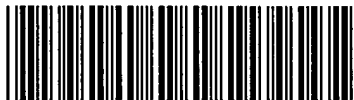


**Search Notes**

Application/Control No.

10/600,014

Examiner

Shew-Fen Lin

Applicant(s)/Patent under  
Reexamination

CHATTERJEE ET AL.

Art Unit

2166

**SEARCHED**

Class	Subclass	Date	Examiner
715	512	11/30/2005	SFL
715	730	11/30/2005	SFL
707	100	11/30/2005	SFL
709	200-250	11/30/2005	SFL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Palm	11/30/2005	SFL
Plus	11/30/2005	SFL
East (US-PUB, USPAT, USOCR, EPO, JPO, IBM-TDB)	11/30/2005	SFL
Consult with Mohammad Ali	11/30/2005	SFL